

## 🌐 Знание языков

Հայերեն English Русский Українська

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### **Analytics for AI Related Applications of Multidimensional Multitape Finite Automata**

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### **Functional Safety Compliant Test & Repair Framework for System-on-Chip Lifecycle Management**

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### **Polynomial algorithm for equivalence problem of deterministic multitape finite automata**

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### **Memory Physical Aware Multi-Level Fault Diagnosis Flow**

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### **Fault Awareness for Memory BIST Architecture Shaped by Multidimensional Prediction Mechanism**

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### **Experimental study on Hamming and Hsiao Codes in the Context of Embedded Applications**

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**Extending fault periodicity table for testing faults in memories under 20nm.**

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